

Page : 1 of 42 Issued date : April 5, 2010

RADIO TEST REPORT

Test Report No.: 30GE0098-YK-E-R1

Applicant : RICOH COMPANY, LTD.

Type of Equipment : Option(s) for Radiocommunications

Model No. : R-WL54C1GN

FCC ID : BBP-WLRW54G2

Test regulation : FCC Part15 Subpart C: 2010

Test result : Complied

- 1. This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc.
- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with the limits of the above regulation.
- 4. The test results in this test report are traceable to the national or international standards.
- 5. This test report must not be used by the customer to claim product certification, approval, or endorsement by any agency of the Federal Government.
- 6. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.
- 7. This report is a revised version of 30GE0098-YK-E. 30GE0098-YK-E is replaced with this report.

Date of test: February 18-20, 23 and March 1-3, 2010

Tested by:

Tatsuya Arai

Engineer of EMC Service

Makoto Hosaka Engineer of EMC Service

M. Hosala

Akio Hayashi

Engineer of EMC Service

Approved by:

Ichiro Isozaki // Leader of EMC Service



The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

There is no testing item of "Non-accreditation".

UL Japan, Inc.

MF060d (06.08.09)

Shonan EMC Lab.

Page : 2 of 42 Issued date : April 5, 2010

| Table of Contents | Page | | | |
|--|------|--|--|--|
| 1 Applicant Information | 3 | | | |
| 2 Equipment under test (E.U.T.) | 3 | | | |
| 3 Test specification, procedures and results | | | | |
| 4 System test configuration | 7 | | | |
| 5 Conducted emission | 9 | | | |
| 6 6dB bandwidth & Occupied bandwidth (99%) | | | | |
| 7 Maximum peak output power | | | | |
| 8 Out of band emissions (Antenna port conducted) | | | | |
| 9 Out of band emissions (Radiated) | | | | |
| 10 Peak power density | | | | |
| | | | | |
| Contents of Appendixes 1 | | | | |
| APPENDIX 1: Photographs of test setup | 14 | | | |
| APPENDIX 2: Test data | 17 | | | |
| APPENDIX 3: Test instruments | 42 | | | |

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 3 of 42 Issued date : April 5, 2010

1 Applicant information

Company Name : RICOH COMPANY, LTD.

Address : 1-3-6 Nakamagome, Ohta-ku, Tokyo, 143-8555 Japan

Telephone Number : +81-3-6890-3804 Facsimile Number : +81-3-5742-5489 Contact Person : Kazuki Kitazawa

2 Equipment under test (E.U.T.)

2.1 Product description

At applicant's sole responsibility, that the differences among the subjected two models, [R-WL54C1GN] and [R-WL54M1GN] are as shown below.

| | Model name | Antenna type | Frequency band |
|---|------------|--------------|--------------------------------|
| FCC ID: BBP-WLRWL542 IC: 144D-WLRWL542 | R-WL54C1N | chip | 2400-2483.5MHz 5150-5350MHz |
| | R-WL54M1N | monopole | 2400-2483.5MHz 5150-5350MHz |
| FCC ID: BBP-WLRW54G2 | R-WL54C1GN | chip | 2400-2483.5MHz |
| IC: 144D-WLRW54G2 | R-WL54M1GN | monopole | 2400-2483.5MHz |

The model [R-WL54M1GN] and [R-WL54C1GN] are prohibited 5GHz band from operating, and it never causes affect on the characteristic of 2.4GHz.

There is no difference among these four models other than that mentioned above.

Therefore, we will use the test data of [R-WL54C1N] for [R-WL54C1GN], and the test data of [R-WL54M1N] for [R-WL54M1GN] in this application.

So we can deem the description of [R-WL54C1N] or [R-WL54M1N] to be [R-WL54C1GN] or [R-WL54M1GN] after this section.

2.2 Identification of E.U.T.

Type of Equipment : Option(s) for Radiocommunications

Model No. : R-WL54C1N
Serial No. : 911S0334
Rating : DC3.3V
Antenna gain : max +1dBi
Country of Mass-production : Japan

Condition of EUT : Production prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No modification by the test lab.

Receipt Date of Sample : February 17, 2010

FCC 15.31 (e)

The RF Module has its own regulator.

The RF Module is constantly provided voltage (DC3.3V, 2.9V, 2.8V, and 1.2V) through its own regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part15.203 Antenna requirement

The antenna is not removable from the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

UL Japan, Inc.

Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 4 of 42 Issued date : April 5, 2010

3 Test specification, procedures and results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2010, final revised on January 22, 2010 and effective

March 1, 2010

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.207 Conducted limits

Section 15.209 Radiated emission limits, general requirements

Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz,

and 5725-5850MHz

FCC Part 15 Subpart B: 2010, final revised on January 22, 2010 and effective March 1, 2010

3.2 Procedures & Results

| Item | Test Procedure | Specification | Remarks | Deviation | Worst Margin | Results |
|--|---|---------------------------------------|----------------------------|-----------|--|----------|
| Ittili | ANSI C63.4:2003 | Specification | Kullai Ks | Deviation | Worst margin | Acsuits |
| Conducted Emission | 7. AC powerline conducted emission measurements | FCC 15.207 | - | N/A | 4.1dB (20.87870MHz, AV, 11g Tx 2437MHz) | Complied |
| 6dB Bandwidth | "Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators | FCC 15.247 (a)(2) & 15.209 | Conducted | N/A | | Complied |
| Maximum Peak Output Power | "Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators | FCC 15.247 (b)(3) & 15.209 | Conducted | N/A | | Complied |
| Out of Band Emission & Restricted Band Edges | "Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators | FCC 15.109, 15.247 (d) & 15.209 | Conducted / Radiated | N/A | 1.9dB (240.000MHz, Horizontal, QP, 11b Tx 2412MHz) | Complied |
| Power Density | "Guidance on Measurement for Digital Transmission Systems Section 15.247" & ANSI C63.4:2003 13. Measurement of intentional radiators | FCC 15.247 (e) | Conducted | N/A | - | Complied |

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

^{*}The revision on January 22, 2010 does not affect the test specification applied to the EUT.

Page : 5 of 42 Issued date : April 5, 2010

3.3 Addition to standard

| Item | Test Procedure | Specification | Remarks | Worst Margin | Results |
|--------------------------|---|---------------|-----------|--------------|----------|
| Occupied bandwidth (99%) | ANSI C63.4:2003 13. Measurement of intentional radiators RSS-Gen 4.6.1 | RSS-Gen 4.6.1 | Conducted | - | Complied |

^{*} Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

| Item | Frequency range | No.1 SAC*1/SR*2 (±) | No.2 SAC/SR (±) | No.3 SAC/SR (±) |
|---|-----------------|---------------------|-----------------|-----------------|
| Conducted emission (AC Mains) AMN/LISN | 150kHz-30MHz | 3.0 dB | 2.6 dB | 3.1 dB |
| Radiated emission | 30MHz-300MHz | 4.6 dB | 4.5 dB | 4.9 dB |
| (Measurement distance: 3m) | 300MHz-1GHz | 4.5 dB | 4.6 dB | 5.1 dB |
| | 1GHz-13GHz | 3.9 dB | 3.9 dB | 4.0 dB |
| Radiated emission | 13GHz-18GHz | 4.8 dB | 4.8 dB | 4.8 dB |
| (Measurement distance: 1m) | 18GHz-40GHz | 4.2 dB | 4.2 dB | 4.2 dB |

^{*1:} SAC=Semi-Anechoic Chamber

Conducted Emission Test

The data listed in this test report has enough margin, more than site margin.

Radiated Emission Test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Conducted emissions, Power Density Measurement (below 1GHz) uncertainty for this test was: (±) 1.1dB

Conducted emissions, Power Density Measurement (1G-3GHz) uncertainty for this test was: (±) 1.2dB

Conducted emissions, Power Density Measurement (3G-18GHz) uncertainty for this test was: (±) 2.9dB

Conducted emissions Measurement (18G-26.5GHz) uncertainty for this test was: (±) 3.4dB

Power Measurement uncertainty above 1GHz for this test was: (±) 0.8dB

Bandwidth Measurement uncertainty for this test was: (±) 5.4%

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

^{*2:} SR= Shielded Room is applied besides radiated emission

Page : 6 of 42 Issued date : April 5, 2010

3.5 Test location

UL Japan, Inc. Shonan EMC Lab.

1-22-3, Megumigaoka, Hiratsuka-shi, Kanagawa-ken 259-1220 JAPAN

Telephone number : +81 463 50 6400 Facsimile number : +81 463 50 6401 JAB Accreditation No. : RTL02610

No.1/ No.2/ No.3 anechoic chamber has been fully described in a report submitted to FCC office, and accepted on

April 17, 2009 (Registration No.: 697847).

IC Registration No. : 2973D-1 (No1 anechoic chamber)

2973D-2 (No2 anechoic chamber) 2973D-3 (No3 anechoic chamber)

| Test room | Width x Depth x Height (m) | Test room | Width x Depth x Height (m) |
|-------------------------------|---|--------------------|----------------------------|
| No.1 Semi-anechoic chamber | 20.6 x 11.3 x 7.65 Maximum measurement distance: 10m | No.1 Shielded room | 6.8 x 4.1 x 2.7 |
| No.2 Semi-anechoic chamber | 20.6 x 11.3 x 7.65 Maximum measurement distance: 10m | No.2 Shielded room | 6.8 x 4.1 x 2.7 |
| No.3 Semi-anechoic chamber | 12.7 x 7.7 x 5.35 Maximum measurement distance: 5m | No.3 Shielded room | 6.3 x 4.7 x 2.7 |
| No.4 Full-anechoic chamber | 8.1 x 5.1 x 3.55 | No.4 Shielded room | 4.4 x 4.7 x 2.7 |
| | | No.5 Shielded room | 7.8 x 6.4 x 2.7 |
| | | No.6 Shielded room | 7.8 x 6.4 x 2.7 |

3.6 Test setup, Data of EMI & Test instruments

Refer to Appendix 1 to 3.

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 7 of 42 Issued date : April 5, 2010

4 System test configuration

4.1 Justification

The system was configured in typical fashion (as a customer would normally use it) for testing.

| Mode | Remarks* | | | |
|---|-------------|--|--|--|
| IEEE 802.11b (11b) | 11Mbps, PN9 | | | |
| IEEE 802.11g (11g) | 6Mbps, PN9 | | | |
| *The worst condition was determined based on the test result of Maximum Peak Output Power (Low Channel) | | | | |

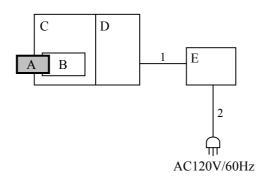
| Test Item | Operating Mode | Tested frequency |
|-----------------------------|-----------------------|-------------------------|
| Conducted Emission | 11b Tx | 2412MHz |
| 6dB Bandwidth | 11g Tx | 2437MHz |
| Occupied Bandwidth (99%) | | 2462MHz |
| Maximum Peak Output Power | | |
| Peak Power Spectral Density | | |
| Out of Band Emissions | | |

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 8 of 42 Issued date : April 5, 2010

4.2 Configuration and peripherals



^{*} Test data was taken under worse case conditions.

Description of EUT and support equipment

| No. | Item | Model number | Serial number | Manufacturer | FCC ID |
|-----|---------------------|--------------|---------------|--------------|--------------|
| | | | | | (Remark) |
| Α | Option(s) for | R-WL54C1N | 911S0334 | RICOH | BBP-WLRWL542 |
| | Radiocommunications | | | | (EUT) |
| В | Extension board1 | ABN105623 | 30590003 | RICOH | (Jig) |
| С | Controller board | Type-DC1S | 612S0038 | RICOH | (Jig) |
| D | Extension board2 | WBG226714 | 60690035 | RICOH | (Jig) |
| Е | PSU | MPT-400 | 2301219567 | RICOH | (Jig) |

List of cables used *1)

| No. | Name | Length (m) | Shield | | Remark |
|-----|----------|------------|------------|------------|--------|
| | | | Cable | Connector | |
| 1 | DC cable | 0.7 | Unshielded | Unshielded | - |
| 2 | AC cable | 2.5 | Unshielded | Unshielded | - |

^{*1)} All cables used for the measurement are exclusive use or marketed.

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 9 of 42 Issued date : April 5, 2010

5 Conducted emission

5.1 Operating environment

The test was carried out in No.1 shielded room.

Temperature : See test data Humidity : See test data

5.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 2m, raised 80cm above the conducting ground plane.

The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of peripherals was aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN) and excess AC cable was bundled in center. Photographs of the set up are shown in Appendix 1.

5.3 Test conditions

Frequency range : 0.15 - 30MHz EUT position : Table top

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT within a screened room. The EUT was connected to a Line Impedance Stabilization Network (LISN).

An overview sweep with peak detection has been performed.

The measurements had been performed with a quasi-peak detector and if required, an average detector.

The conducted emission measurements were made with the following detector of the test receiver.

Detector Type : Quasi-Peak/ Average

IF Bandwidth : 9kHz

5.5 Results

Summary of the test results: Pass

Date: March 3, 2010 Test engineer: Tatsuya Arai

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 10 of 42 Issued date : April 5, 2010

6 6dB bandwidth & Occupied bandwidth (99%)

Test procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.

Summary of the test results: Pass

Date: March 2, 2010 Test engineer: Akio Hayashi

7 Maximum peak output power

Test procedure

The Maximum Peak Output Power was measured with a power meter connected to the antenna port.

Summary of the test results: Pass

Date: February 18, 2010 Test engineer: Akio Hayashi

8 Out of band emissions (Antenna port conducted)

Test procedure

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port. In any 100kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.

Summary of the test results: Pass

Date : March 1, 2010 Test engineer : Akio Hayashi

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 11 of 42 Issued date : April 5, 2010

9 Out of band emissions (Radiated)

9.1 Operating environment

The test was carried out in No.3 anechoic chamber.

9.2 Test configuration

EUT was placed on a urethane platform of nominal size, 0.5m by 0.5m, raised 80cm above the conducting ground plane. Photographs of the set up are shown in Appendix 1.

9.3 Test conditions

Frequency range : 30MHz - 26GHz

9.4 Test procedure

The Radiated Electric Field Strength intensity has been measured with a ground plane and at a distance of 3m(below 13GHz) and 1m(above13GHz).

The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

Measurements were performed with QP, PK, and AV detector.

The radiated emission measurements were made with the following detector function of the test receiver.

| Frequency | Below 1GHz | Above 1GHz |
|-------------------|---------------------------|--|
| Instrument used | Test Receiver | Spectrum Analyzer *1) |
| Detector IF | QP: BW 120kHz | PK: RBW: 1MHz/VBW: 1MHz, |
| Bandwidth | | AV RBW: 1MHz |
| | | VBW: 10Hz (No pulse emission detected) |
| Measuring antenna | Biconical (30-300MHz) | Horn |
| | Logperiodic (300MHz-1GHz) | |
| Test distance | 3m | 3m(below 13GHz) |
| | | 1m(above 13GHz) |

^{*1)} When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

The equipment was previously checked at each position of three axes X, Y and Z. The position in which the maximum noise occurred was chosen to put into measurement. See the photographs in appendix.

9.5 Band edge

Band edge level at 2400MHz is less than 20dB of peak point of the carrier. Refer to the data of Out of Band Emissions (Antenna Port Conducted). Band edge level at 2390MHz and 2483.5MHz is below the limits of FCC 15.209. Refer to the data of Radiated emission.

9.6 Results

Summary of the test results: Pass

Date : February 19, 20 and 23, 2010 Test engineer : Akio Hayashi and Makoto Hosaka

UL Japan, Inc. Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 12 of 42 Issued date : April 5, 2010

10 Peak power density

Test procedure

The peak power density was measured with a spectrum analyzer connected to the antenna port.

Instrument used : Spectrum Analyzer *1)
RBW / VBW : 30kHz / 100kHz *2)

- *1) PSD Option 1 of "Measurement of Digital Transmission Systems Operating under Section 15.247".
- *2) The test was not performed at RBW: 3kHz that was stated in the Regulation.

However, the measurement value with RBW: 3kHz is less than the value of RBW: 30kHz and the test data met the limit with RBW: 30kHz.

Summary of the test results: Pass

Date: March 2, 2010 Test engineer: Akio Hayashi

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Page : 13 of 42 Issued date : April 5, 2010

APPENDIX 1: Photographs of test setup

Page 14 : Conducted emission

Page 15 : Radiated emission

Page 16 : Pre-check of the worst position

APPENDIX 2: Test data

Page 17 - 22 : Conducted emission

Page 23 - 24 : 6dB bandwidth

Page 25 : Maximum peak output power

Page 26 - 31 : Out of band emissions (Radiated)

Page 32 - 38 : Out of band emissions (Antenna port conducted)

Page 39 - 40 : Peak power density

Page 41 : Occupied bandwidth

APPENDIX 3: Test instruments

Page 42 : Test instruments

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN